

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test

(41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 155.1 V/m; Power Drift = 0.01 dB

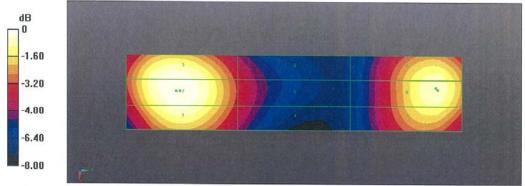
Applied MIF = 0.00 dB

RF audio interference level = 39.24 dBV/m

Emission category: M2

MIF scaled E-field

Grid 2 M2 39.24 dBV/m	Grid 3 M2 39.15 dBV/m
Grid 5 M2 37.16 dBV/m	PARTICIPATION STANDONS
Grid 8 M2 38.83 dBV/m	Control of the Contro



0 dB = 139.3 V/m = 42.88 dBV/m



Dipole 2450 MHz

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Client

CTTL (Auden)

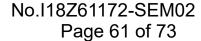
Certificate No: CD2450V3-1021 Aug17

Accreditation No.: SCS 0108

The state of the s	CERTIFICAT		
Object	CD2450V3 - SN: 1021		
Calibration procedure(s)	QA CAL-20.v6 Calibration proce	edure for dipoles in air	
Calibration date:	August 23, 2017		
The measurements and the unce	rtainties with confidence p	onal standards, which realize the physical unitrobability are given on the following pages and $\frac{1}{2}$ yfacility: environment temperature (22 \pm 3)°C	d are part of the certificate.
Calibration Equipment used (M&	TE critical for calibration)		
Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	04-Apr-17 (No. 217-02521/02522)	Apr-18
	011 400044	0.4 4 47 (1) 0.47 0.47 0.47	
Power sensor NRP-Z91	SN: 103244	04-Apr-17 (No. 217-02521)	Apr-18
	SN: 103244 SN: 103245	04-Apr-17 (No. 217-02521) 04-Apr-17 (No. 217-02522)	Apr-18 Apr-18
Power sensor NRP-Z91			Apr-18
Power sensor NRP-Z91 Reference 20 dB Attenuator	SN: 103245	04-Apr-17 (No. 217-02522)	Apr-18 Apr-18
Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination	SN: 103245 SN: 5058 (20k)	04-Apr-17 (No. 217-02522) 07-Apr-17 (No. 217-02528)	Apr-18
Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6	SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327	04-Apr-17 (No. 217-02522) 07-Apr-17 (No. 217-02528) 07-Apr-17 (No. 217-02529)	Apr-18 Apr-18 Apr-18
Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4	SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336	04-Apr-17 (No. 217-02522) 07-Apr-17 (No. 217-02528) 07-Apr-17 (No. 217-02529) 30-Dec-16 (No. ER3-2336_Dec16)	Apr-18 Apr-18 Apr-18 Dec-17
Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards	SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065	04-Apr-17 (No. 217-02522) 07-Apr-17 (No. 217-02528) 07-Apr-17 (No. 217-02529) 30-Dec-16 (No. ER3-2336_Dec16) 30-Dec-16 (No. H3-6065_Dec16)	Apr-18 Apr-18 Apr-18 Dec-17 Dec-17
Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B	SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781	04-Apr-17 (No. 217-02522) 07-Apr-17 (No. 217-02528) 07-Apr-17 (No. 217-02529) 30-Dec-16 (No. ER3-2336_Dec16) 30-Dec-16 (No. H3-6065_Dec16) 13-Jul-17 (No. DAE4-781_Jul17)	Apr-18 Apr-18 Apr-18 Dec-17 Dec-17 Jul-18
Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A	SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781	04-Apr-17 (No. 217-02522) 07-Apr-17 (No. 217-02528) 07-Apr-17 (No. 217-02529) 30-Dec-16 (No. ER3-2336_Dec16) 30-Dec-16 (No. H3-6065_Dec16) 13-Jul-17 (No. DAE4-781_Jul17)	Apr-18 Apr-18 Apr-18 Dec-17 Dec-17 Jul-18 Scheduled Check
Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A	SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781	04-Apr-17 (No. 217-02522) 07-Apr-17 (No. 217-02528) 07-Apr-17 (No. 217-02529) 30-Dec-16 (No. ER3-2336_Dec16) 30-Dec-16 (No. H3-6065_Dec16) 13-Jul-17 (No. DAE4-781_Jul17) Check Date (in house) 09-Oct-09 (in house check Sep-14)	Apr-18 Apr-18 Apr-18 Dec-17 Dec-17 Jul-18 Scheduled Check In house check: Oct-17
Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A	SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB42420191 SN: US38485102	04-Apr-17 (No. 217-02522) 07-Apr-17 (No. 217-02528) 07-Apr-17 (No. 217-02529) 30-Dec-16 (No. ER3-2336_Dec16) 30-Dec-16 (No. H3-6065_Dec16) 13-Jul-17 (No. DAE4-781_Jul17) Check Date (in house) 09-Oct-09 (in house check Sep-14) 05-Jan-10 (in house check Sep-14)	Apr-18 Apr-18 Apr-18 Dec-17 Dec-17 Jul-18 Scheduled Check In house check: Oct-17 In house check: Oct-17
Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A RF generator R&S SMT-06	SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB42420191 SN: US38485102 SN: US37295597	04-Apr-17 (No. 217-02522) 07-Apr-17 (No. 217-02528) 07-Apr-17 (No. 217-02529) 30-Dec-16 (No. ER3-2336_Dec16) 30-Dec-16 (No. H3-6065_Dec16) 13-Jul-17 (No. DAE4-781_Jul17) Check Date (in house) 09-Oct-09 (in house check Sep-14) 05-Jan-10 (in house check Sep-14) 09-Oct-09 (in house check Sep-14)	Apr-18 Apr-18 Apr-18 Dec-17 Dec-17 Jul-18 Scheduled Check In house check: Oct-17 In house check: Oct-17
Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A RF generator R&S SMT-06 Network Analyzer HP 8753E	SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB42420191 SN: US38485102 SN: US37295597 SN: 832283/011 SN: US37390585 Name	04-Apr-17 (No. 217-02522) 07-Apr-17 (No. 217-02528) 07-Apr-17 (No. 217-02529) 30-Dec-16 (No. ER3-2336_Dec16) 30-Dec-16 (No. H3-6065_Dec16) 13-Jul-17 (No. DAE4-781_Jul17) Check Date (in house) 09-Oct-09 (in house check Sep-14) 05-Jan-10 (in house check Sep-14) 27-Aug-12 (in house check Oct-15) 18-Oct-01 (in house check Oct-16) Function	Apr-18 Apr-18 Apr-18 Dec-17 Dec-17 Jul-18 Scheduled Check In house check: Oct-17 In house check: Oct-17 In house check: Oct-17 In house check: Oct-17
Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP E4412A Power sensor HP 8482A RF generator R&S SMT-06	SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 2336 SN: 6065 SN: 781 ID # SN: GB42420191 SN: US38485102 SN: US37295597 SN: 832283/011 SN: US37390585	04-Apr-17 (No. 217-02522) 07-Apr-17 (No. 217-02528) 07-Apr-17 (No. 217-02529) 30-Dec-16 (No. ER3-2336_Dec16) 30-Dec-16 (No. H3-6065_Dec16) 13-Jul-17 (No. DAE4-781_Jul17) Check Date (in house) 09-Oct-09 (in house check Sep-14) 09-Oct-09 (in house check Sep-14) 09-Oct-09 (in house check Cep-14) 27-Aug-12 (in house check Oct-15) 18-Oct-01 (in house check Oct-16)	Apr-18 Apr-18 Apr-18 Dec-17 Dec-17 Jul-18 Scheduled Check In house check: Oct-17

Certificate No: CD2450V3-1021_Aug17

Page 1 of 8





Calibration Laboratory of

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References

[1] ANSI-C63.19-2007

American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

[2] ANSI-C63.19-2011

American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna
 (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes.
 In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a
 distance of 10 mm (15 mm for [2]) above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1] and [2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (15 mm for [2]) (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
 antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The
 maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as
 calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the
 feed point.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: CD2450V3-1021_Aug17 Page 2 of 8



Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.0
Phantom	HAC Test Arch	102.10.0
Distance Dipole Top - Probe Center	10, 15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	2450 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 2450 MHz

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW input power	0.502 A/m ± 8.2 % (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	138.6 V/m = 42.84 dBV/m
Maximum measured above low end	100 mW input power	135.6 V/m = 42.64 dBV/m
Averaged maximum above arm	100 mW input power	137.1 V/m ± 12.7 % (k=2)

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	92.0 V/m = 39.28 dBV/m
Maximum measured above low end	100 mW input power	85.7 V/m = 38.66 dBV/m
Averaged maximum above arm	100 mW input power	88.9 V/m ± 12.8 % (k=2)



Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance
2250 MHz	17.4 dB	64.8 Ω + 4.2 jΩ
2350 MHz	29.6 dB	52.1 Ω - 2.6 jΩ
2450 MHz	27.6 dB	54.2 Ω - 1.0 jΩ
2550 MHz	31.5 dB	50.8 Ω - 2.6 jΩ
2650 MHz	18.2 dB	61.4 Ω - 7.5 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

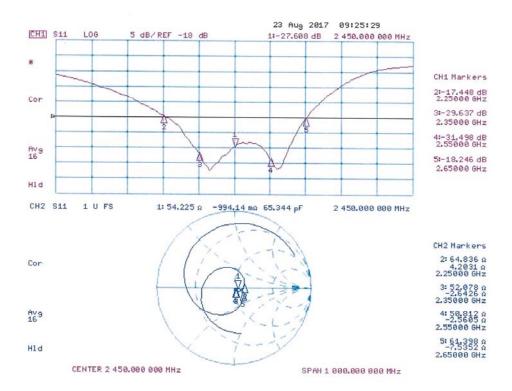
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.



Impedance Measurement Plot





DASY5 H-field Result

Date: 22.08.2017

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 2450 MHz; Type: CD2450V3; Serial: CD2450V3 - SN: 1021

Communication System: UID 0 - CW ; Frequency: 2450 MHz Medium parameters used: $\sigma=0$ S/m, $\epsilon_r=1$; $\rho=1$ kg/m 3

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 30.12.2016
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 13.07.2017
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.0(1446); SEMCAD X 14.6.10(7417)

Dipole H-Field measurement @ 2450MHz/H-Scan - 2450MHz d=10mm/Hearing Aid Compatibility Test

(41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

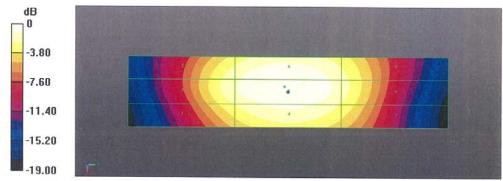
Reference Value = 0.5270 A/m; Power Drift = -0.01 dB

PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.5022 A/m Near-field category: M2 (AWF 0 dB)

PMF scaled H-field

Grid 1 M2 0.379 A/m		
Grid 4 M2 0.455 A/m	Grid 5 M2 0.502 A/m	
Grid 7 M2 0.370 A/m		



0 dB = 0.5022 A/m = -5.98 dBA/m

Certificate No: CD2450V3-1021_Aug17



DASY5 E-field Result

Date: 22.08.2017

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 2450 MHz; Type: CD2450V3; Serial: CD2450V3 - SN: 1021

Communication System: UID 0 - CW ; Frequency: 2450 MHz Medium parameters used: σ = 0 S/m, ϵ_r = 1; ρ = 1000 kg/m³

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 30.12.2016;

Sensor-Surface: (Fix Surface)

Electronics: DAE4 Sn781; Calibrated: 13.07.2017

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070

DASY52 52.10.0(1446); SEMCAD X 14.6.10(7417)

Dipole E-Field measurement @ 2450MHz/E-Scan - 2450MHz d=10mm/Hearing Aid Compatibility Test

(41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 86.46 V/m; Power Drift = 0.00 dB

Applied MIF = 0.00 dB

RF audio interference level = 42.84 dBV/m

Emission category: M1

MIF scaled E-field

Grid 1 M1 42.29 dBV/m		Grid 3 M1 42.72 dBV/m
Grid 4 M1 41.16 dBV/m	THE RESIDENCE OF THE PARTY OF T	
Grid 7 M1 42.02 dBV/m		Grid 9 M1 42.57 dBV/m



Dipole E-Field measurement @ 2450MHz/E-Scan - 2450MHz d=15mm/Hearing Aid Compatibility Test

(41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 86.21 V/m; Power Drift = 0.02 dB

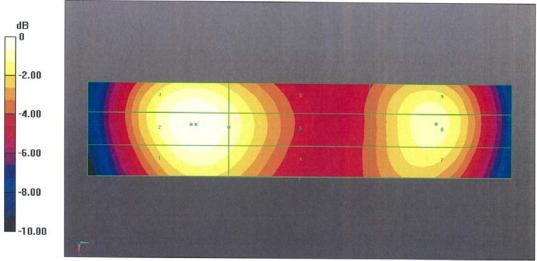
Applied MIF = 0.00 dB

RF audio interference level = 39.28 dBV/m

Emission category: M2

MIF scaled E-field

		Grid 3 M2
38.99 dBV/m	39.28 dBV/m	39.2 dBV/m
	Grid 5 M2 38.75 dBV/m	
Carlo III a de la carlo III de	Grid 8 M2 38.66 dBV/m	Grid 9 M2 38.62 dBV/m



0 dB = 138.6 V/m = 42.84 dBV/m

Certificate No: CD2450V3-1021_Aug17



ANNEX F DAE CALIBRATION CERTIFICATE

Calibration Laboratory of Schmid & Partner **Engineering AG** Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

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Client CTTL (Auden) Certificate No: DAE4-777_Sep17

Accreditation No.: SCS 0108

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CALIBRATION CERTIFICATE Object DAE4 - SD 000 D04 BM - SN: 777 Calibration procedure(s) QA CAL-06.v29 Calibration procedure for the data acquisition electronics (DAE) Calibration date: September 08, 2017 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID# Cal Date (Certificate No.) Scheduled Calibration Keithley Multimeter Type 2001 SN: 0810278 31-Aug-17 (No:21092) Aug-18 Secondary Standards ID# Check Date (in house) Scheduled Check Auto DAE Calibration Unit SE UWS 053 AA 1001 05-Jan-17 (in house check) In house check: Jan-18 Calibrator Box V2.1 SE UMS 006 AA 1002 05-Jan-17 (in house check) In house check: Jan-18 Name Function Signature Calibrated by: Dominique Steffen Laboratory Technician Approved by: Sven Kühn Deputy Manager Issued: September 8, 2017 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: DAE4-777_Sep17 Page 1 of 5





Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

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Glossary

DAE Connector angle data acquisition electronics

information used in DASY system to align probe sensor X to the robot

coordinate system.

Methods Applied and Interpretation of Parameters

 DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.

- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

Certificate No: DAE4-777_Sep17 Page 2 of 5



DC Voltage Measurement
A/D - Converter Resolution nominal
High Range: 1LSB = 6.1μV , full range = -100...+300 mV full range = -1......+3mV Low Range: 1LSB = 61nV, DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Υ	z
High Range	405.400 ± 0.02% (k=2)	405.869 ± 0.02% (k=2)	405.579 ± 0.02% (k=2)
		3.96264 ± 1.50% (k=2)	

Connector Angle

Connector Angle to be used in DASY system	97.0°±1°
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Certificate No: DAE4-777_Sep17



Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	200022.73	-12.42	-0.01
Channel X + Input	20003.49	-1.25	-0.01
Channel X - Input	-19998.82	6.77	-0.03
Channel Y + Input	200025.10	-10.04	-0.01
Channel Y + Input	20007.22	2.54	0.01
Channel Y - Input	-20002.34	3.30	-0.02
Channel Z + Input	200028.10	-6.82	-0.00
Channel Z + Input	20002.36	-2.19	-0.01
Channel Z - Input	-20003.64	2.12	-0.01

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2000.54	-0.37	-0.02
Channel X + Input	201.37	0.50	0.25
Channel X - Input	-199.19	-0.20	0.10
Channel Y + Input	1999.95	-0.89	-0.04
Channel Y + Input	200.04	-0.75	-0.37
Channel Y - Input	-199.96	-0.85	0.43
Channel Z + Input	2001.05	0.20	0.01
Channel Z + Input	199.88	-0.86	-0.43
Channel Z - Input	-200.02	-0.88	0.44

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	5.45	3.79
	- 200	3.93	0.83
Channel Y	200	7.70	7.39
	- 200	-9.52	-8.90
Channel Z	200	7.51	6.49
	- 200	-9.21	-8.71

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (µV)	Channel Z (μV)
Channel X	200	-	-1.61	-2.84
Channel Y	200	8.30		0.46
Channel Z	200	6.69	5.02	-

Certificate No: DAE4-777_Sep17



4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15919	14652
Channel Y	16343	14477
Channel Z	16033	14911

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 seo; Measuring time: 3 sec

Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (µV)
Channel X	-0.50	-2.04	0.95	0.51
Channel Y	1.56	0.40	2.80	0.48
Channel Z	0.26	-0.78	1.16	0.42

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9



The photos of HAC test are presented in the additional document:

Appendix to test report No.I18Z61172-SEM02/03

The photos of HAC test